



PATENT APPLICATION

IN THE U.S. PATENT AND TRADEMARK OFFICE

June 29, 2004

Applicant(s) : Wenjie DENG et al.
For : SURGICAL CUTTING ACCESSORY WITH ENCAPSULATED
RFID CHIP
Serial No. : 10/782 374 Group: 3731
Confirmation No.: 3567
Filed : February 19, 2004 Examiner: Unknown
International Application No. : N/A
International Filing Date : N/A
Atty. Docket No.: S*EN C-268A

Mail Stop Missing Parts
Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

INFORMATION DISCLOSURE STATEMENT

Sir:

The above-identified patent application is a CIP of U.S. Serial No. 10/319 300, filed December 13, 2002, which is a CIP of U.S. Serial No. 10/214 937, filed August 8, 2002. In compliance with the provisions of Rules 1.97(b)(1) and 1.98, enclosed herewith is Form PTO-1449 identifying the prior art of record submitted in the parent applications. Pursuant to MPEP §609, copies of the cited references are not supplied since they may be found in the parent applications.

No further information is believed necessary at this time, and Applicant respectfully requests confirmation that all of the prior art of record in the parent application has been considered herein.

Respectfully submitted,


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Encl: Form PTO-1449

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U.S. PATENT DOCUMENTS

Examiner Initial*	Document Number	Date	Name	Class	Sub Class	Filing Date
AA	2003/0093103	05/2003	Malackowski et al.			
AB	Re. 34 556	03/1994	Sjostrom et al.			
AC	4 355 977	10/1982	Ota et al.			
AD	4 705 038	11/1987	Sjostrom et al.			
AE	5 192 292	03/1993	Cezana et al.			
AF	5 400 267	03/1995	Denen et al.			
AG	5 443 082	08/1995	Mewburn			
AH	5 460 490	10/1995	Carr et al.			
AI	5 628 731	05/1997	Dodge et al.			
AJ	5 632 759	05/1997	Rexroth			
AK	5 747 953	05/1998	Philipp			
AL	5 810 770	09/1998	Chin et al.			
AM	6 017 354	01/2000	Culp et al.			
AN	6 092 722	07/2000	Heinrichs et al.			
AO	6 126 670	10/2000	Walker et al.			
AP	6 312 441	11/2001	Deng			
EXAMINER			DATE CONSIDERED			

*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant.

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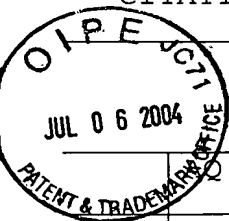
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FOREIGN PATENT DOCUMENTS

Document Number	Date	Country	Class	Sub Class	Translation Yes	No
EP 0630820 A1	12/1994	Europe			Abstract	
EP 0951921 A2	10/1999	Europe				
EP 1110504 A2	06/2001	Europe				
DE 3917876 A1	12/1990	Germany			Abstract	
JP 7-178107	07/1995	Japan			X	
NL 1001018	02/1997	Netherlands			X	
WO 94/10921	05/1994	WIPO				
WO 00/24318	05/2000	WIPO				

OTHER DOCUMENTS (Including Author, Title, Date, Pages, Etc.)

BA	Partial European Patent Office Search Report dated November 27, 2002 (2 pages)
BB	International Search Report dated March 3, 2003 (5 pages)
BC	U.S. Patent Application Serial No. 10/210 325, filed August 1, 2002 (64 pages)
BD	U.S. Provisional Patent Application Serial No. 60/395 881, filed July 15, 2002 (46 pages)

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